

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HEIKKILA ET AL.	
		Examiner Magda Cruz	Art Unit 2851	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,577,355	06-2003	Yaniv, Zvi	349/16
*	B	US-6,844,967	01-2005	Teramoto et al.	359/443
*	C	US-5,123,192	06-1992	Hsieh, Chi-Sheng	40/442
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.